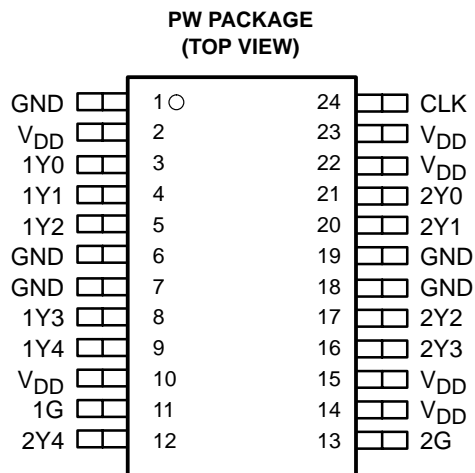


# CDCVF2310

## 2.5-V TO 3.3-V HIGH PERFORMANCE CLOCK BUFFER

SCAS666A – JUNE 2001 – REVISED AUGUST 2002

- **High Performance 1:10 Clock Driver for General Purpose Applications. Operates up to 200 MHz at V<sub>DD</sub> 3.3 V**
- **Pin-to-Pin Skew < 100 ps at V<sub>DD</sub> 3.3 V**
- **V<sub>DD</sub> Range: 2.3 V to 3.6 V**
- **Operating Temperature Range –40°C to 85°C**
- **Output Enable Glitch Suppression**
- **Distributes One Clock Input to Two Banks of Five Outputs**
- **25-Ω On-Chip Series Damping Resistors**
- **Packaged in 24-Pin TSSOP**



### description

The CDCVF2310 is a high-performance, low-skew clock buffer that operates up to 200 MHz. Two banks of five outputs each provide low-skew copies of CLK. Through the use of the control pins 1G and 2G, the outputs of bank 1Y(0:4) and 2Y(0:4) can be placed in a low state regardless of the CLK input. The device operates in a 2.5-V and 3.3-V environment. The built-in output enable glitch suppression ensures a synchronized output enable sequence to distribute full period clock signals.

The CDCVF2310 is characterized for operation from –40°C to 85°C.



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PRODUCTION DATA information is current as of publication date. Products conform to specifications per the terms of Texas Instruments standard warranty. Production processing does not necessarily include testing of all parameters.

**TEXAS  
INSTRUMENTS**

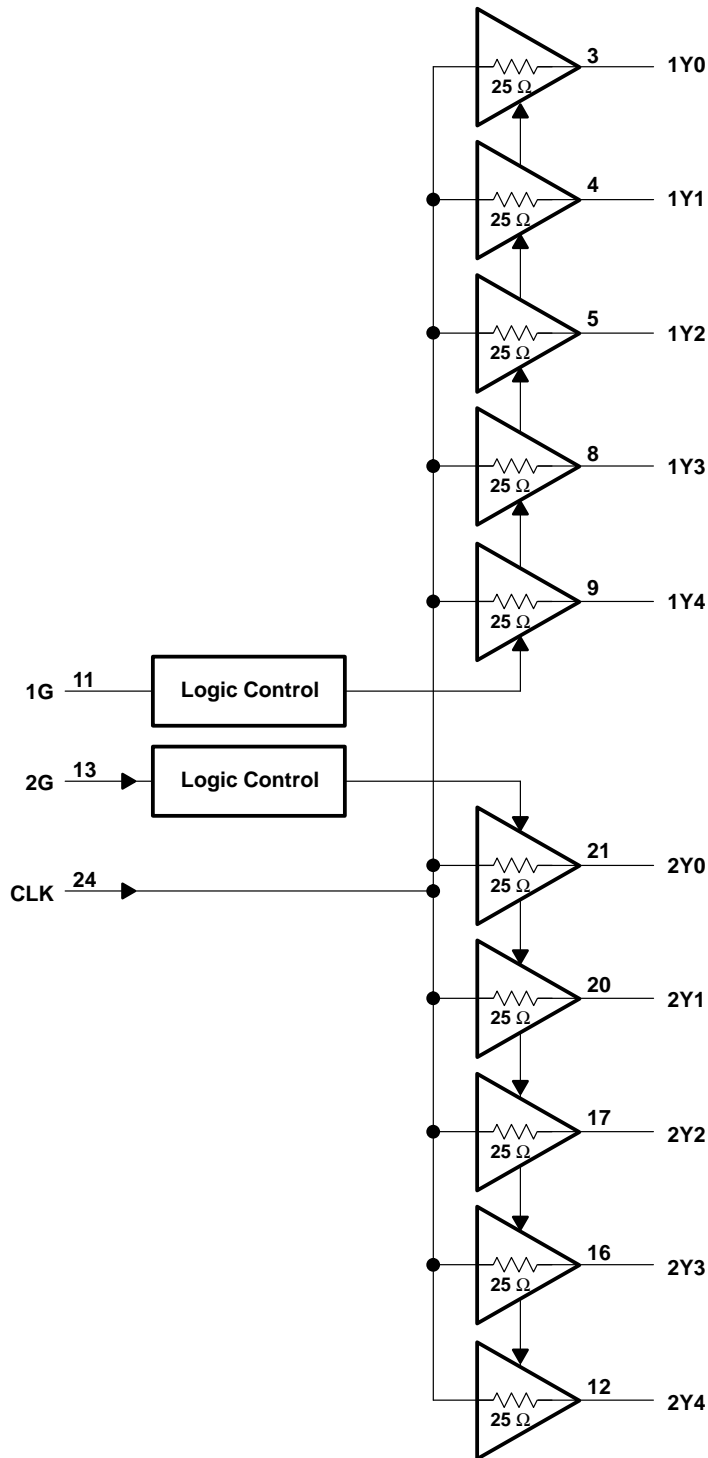
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# CDCVF2310 2.5-V TO 3.3-V HIGH PERFORMANCE CLOCK BUFFER

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## functional block diagram



# CDCVF2310

## 2.5-V TO 3.3-V HIGH PERFORMANCE CLOCK BUFFER

SCAS666A – JUNE 2001 – REVISED AUGUST 2002

The 1G and 2G output enables are active high. For example, if the 1G pin is logic high, the 1Y(0:4) outputs will follow the input CLK. If 1G is logic low, the 1Y(0:4) outputs will drive low, independent of the state of the input clock.

**FUNCTION TABLE**

INPUT			OUTPUT	
1G	2G	CLK	1Y(0:4)	2Y(0:4)
L	L	X	L	L
H	L	H	H	L
L	H	H	L	H
H	H	H	H	H

### Terminal Functions

TERMINAL NAME	TERMINAL NO.	I/O	DESCRIPTION
1G	11	I	Output enable control for 1Y(0:4) outputs. This output enable is active high meaning the 1Y(0:4) clock outputs will follow the input clock (CLK) if this pin is logic high. If this pin is logic low, the 1Y(0:4) outputs will drive low independent of the state of CLK.
2G	13	I	Output enable control for 2Y(0:4) outputs. This output enable is active high meaning the 2Y(0:4) clock outputs will follow the input clock (CLK) if this pin is logic high. If this pin is logic low, the 2Y(0:4) outputs will drive low independent of the state of CLK.
1Y[0:4]	3, 4, 5, 8, 9	O	Buffered output clocks
2Y(0:4)	21, 20, 17, 16, 12	O	Buffered output clocks
CLK	24	I	Input reference frequency
GND	1, 6, 7, 18, 19		Ground
VDD	2, 10, 14, 15, 22, 23	Power	DC power supply, 2.3 V – 3.6 V

# CDCVF2310

## 2.5-V TO 3.3-V HIGH PERFORMANCE CLOCK BUFFER

SCAS666A – JUNE 2001 – REVISED AUGUST 2002

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### detailed description

#### output enable glitch suppression circuit

The purpose of the glitch suppression circuitry is to ensure the output enable sequence is synchronized with the clock input such that the output buffer will be enabled on the next full period of the input clock (negative edge triggered by the input clock). The G input must be stable one  $t_{en}$  – time prior to the falling edge of the CLK for predictable operation.

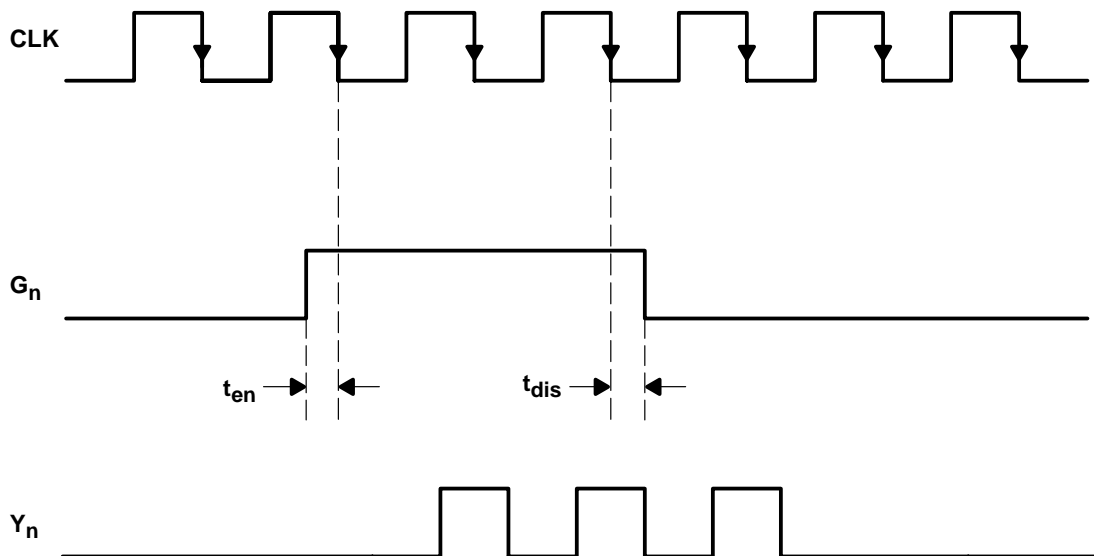


Figure 1. G ( $t_{en}$ ,  $t_{dis}$ ) Relative to CLK↓

# CDCVF2310

## 2.5-V TO 3.3-V HIGH PERFORMANCE CLOCK BUFFER

SCAS666A – JUNE 2001 – REVISED AUGUST 2002

### absolute maximum ratings over operating free-air temperature (unless otherwise noted)†

Supply voltage range, $V_{DD}$ .....	–0.5 V to 4.6 V
Input voltage range, $V_I$ (see Notes 1 and 2) .....	–0.5 V to $V_{DD} + 0.5$ V
Output voltage range, $V_O$ (see Notes 1 and 2) .....	–0.5 V to $V_{DD} + 0.5$ V
Input clamp current, $I_{IK}$ ( $V_I < 0$ or $V_I > V_{DD}$ ) .....	±50 mA
Output clamp current, $I_{OK}$ ( $V_O < 0$ or $V_O > V_{DD}$ ) .....	±50 mA
Continuous total output current, $I_O$ ( $V_O = 0$ to $V_{DD}$ ) .....	±50 mA
Package thermal impedance, $\theta_{JA}$ (see Note 3): PW package .....	120°C/W
Storage temperature range $T_{stg}$ .....	–65°C to 150°C

† Stresses beyond those listed under “absolute maximum ratings” may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under “recommended operating conditions” is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

- NOTES: 1. The input and output negative voltage ratings may be exceeded if the input and output clamp-current ratings are observed.  
 2. This value is limited to 4.6 V maximum.  
 3. The package thermal impedance is calculated in accordance with JESD 51.

### recommended operating conditions

		MIN	NOM	MAX	UNIT
Supply voltage, $V_{DD}$		2.3	2.5		V
			3.3	3.6	
Low-level input voltage, $V_{IL}$	$V_{DD} = 3$ V to 3.6 V			0.8	V
	$V_{DD} = 2.3$ V to 2.7 V			0.7	
High-level input voltage, $V_{IH}$	$V_{DD} = 3$ V to 3.6 V	2			V
	$V_{DD} = 2.3$ V to 2.7 V	1.7			
Input voltage, $V_I$		0		$V_{DD}$	V
High-level output current, $I_{OH}$	$V_{DD} = 3$ V to 3.6 V			–12	mA
	$V_{DD} = 2.3$ V to 2.7 V			–6	
Low-level output current, $I_{OL}$	$V_{DD} = 3$ V to 3.6 V			12	mA
	$V_{DD} = 2.3$ V to 2.7 V			6	
Operating free-air temperature, $T_A$		–40		85	°C



# CDCVF2310

## 2.5-V TO 3.3-V HIGH PERFORMANCE CLOCK BUFFER

SCAS666A – JUNE 2001 – REVISED AUGUST 2002

### electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
V <sub>IK</sub> Input voltage	V <sub>DD</sub> = 3 V, I <sub>I</sub> = -18 mA			-1.2	V
I <sub>I</sub> Input current	V <sub>I</sub> = 0 V or V <sub>DD</sub>			±5	μA
I <sub>DD</sub> <sup>†</sup> Static device current	CLK = 0 V or V <sub>DD</sub> , I <sub>O</sub> = 0 mA, V <sub>DD</sub> = 3.3 V			25	μA
C <sub>I</sub> Input capacitance	V <sub>DD</sub> = 2.3 V to 3.6 V, V <sub>I</sub> = 0 V or V <sub>DD</sub>		2.5		pF
C <sub>O</sub> Output capacitance	V <sub>DD</sub> = 2.3 V to 3.6 V, V <sub>I</sub> = 0 V or V <sub>DD</sub>		2.8		pF

<sup>†</sup> For I<sub>DD</sub> over frequency see Figure 5.

#### V<sub>DD</sub> = 3.3 V ±0.3 V

PARAMETER	TEST CONDITIONS	MIN	TYP <sup>‡</sup>	MAX	UNIT
V <sub>OH</sub> High-level output voltage	V <sub>DD</sub> = min to max, I <sub>OH</sub> = -100 μA	V <sub>DD</sub> - 0.2			V
	V <sub>DD</sub> = 3 V	I <sub>OH</sub> = -12 mA	2.1		
		I <sub>OH</sub> = -6 mA	2.4		
V <sub>OL</sub> Low-level output voltage	V <sub>DD</sub> = min to max, I <sub>OL</sub> = -100 μA			0.2	V
	V <sub>DD</sub> = 3 V	I <sub>OL</sub> = 12 mA		0.8	
		I <sub>OL</sub> = 6 mA		0.55	
I <sub>OH</sub> High-level output current	V <sub>DD</sub> = 3 V, V <sub>O</sub> = 1 V	-28			mA
	V <sub>DD</sub> = 3.3 V, V <sub>O</sub> = 1.65 V		-36		
	V <sub>DD</sub> = 3.6 V, V <sub>O</sub> = 3.135 V		-14		
I <sub>OL</sub> Low-level output current	V <sub>DD</sub> = 3 V, V <sub>O</sub> = 1.95 V	28			mA
	V <sub>DD</sub> = 3.3 V, V <sub>O</sub> = 1.65 V		36		
	V <sub>DD</sub> = 3.6 V, V <sub>O</sub> = 0.4 V		14		

<sup>‡</sup> All typical values are at respective nominal V<sub>DD</sub>.

#### V<sub>DD</sub> = 2.5 V ±0.2 V

PARAMETER	TEST CONDITIONS	MIN	TYP <sup>‡</sup>	MAX	UNIT
V <sub>OH</sub> High-level output voltage	V <sub>DD</sub> = min to max, I <sub>OH</sub> = -100 μA	V <sub>DD</sub> - 0.2			V
	V <sub>DD</sub> = 2.3 V, I <sub>OH</sub> = -6 mA	1.8			
V <sub>OL</sub> Low-level output voltage	V <sub>DD</sub> = min to max, I <sub>OL</sub> = 100 μA			0.2	V
	V <sub>DD</sub> = 2.3 V, I <sub>OL</sub> = 6 mA			0.55	
I <sub>OH</sub> High-level output current	V <sub>DD</sub> = 2.3 V, V <sub>O</sub> = 1 V	-17			mA
	V <sub>DD</sub> = 2.5 V, V <sub>O</sub> = 1.25 V		-25		
	V <sub>DD</sub> = 2.7 V, V <sub>O</sub> = 2.375 V		-10		
I <sub>OL</sub> Low-level output current	V <sub>DD</sub> = 2.3 V, V <sub>O</sub> = 1.2 V	17			mA
	V <sub>DD</sub> = 2.5 V, V <sub>O</sub> = 1.25 V		25		
	V <sub>DD</sub> = 2.7 V, V <sub>O</sub> = 0.3 V		10		

<sup>‡</sup> All typical values are at respective nominal V<sub>DD</sub>.

### timing requirements over recommended ranges of supply voltage and operating free-air temperature

		MIN	NOM	MAX	UNIT
f <sub>clk</sub> Clock frequency	V <sub>DD</sub> = 3 V to 3.6 V	0		200	MHz
	V <sub>DD</sub> = 2.3 V to 2.7 V	0		170	



# CDCVF2310

## 2.5-V TO 3.3-V HIGH PERFORMANCE CLOCK BUFFER

SCAS666A – JUNE 2001 – REVISED AUGUST 2002

**switching characteristics over recommended operating free-air temperature range (unless otherwise noted)**

**$V_{DD} = 3.3\text{ V} \pm 0.3\text{ V}$  (see Figure 2)**

PARAMETER		TEST CONDITIONS	MIN	TYP†	MAX	UNIT
t <sub>PLH</sub>	CLK to Y <sub>n</sub> (see Figure 2)	f = 0 MHz to 200 MHz	1.3		2.8	ns
t <sub>PHL</sub>						
t <sub>sk(o)</sub>	Output skew (Y <sub>n</sub> to Y <sub>n</sub> ) (see Note 4 and Figure 4)				100	ps
t <sub>sk(p)</sub>	Pulse skew (see Figure 5)				250	ps
t <sub>sk(pp)</sub>	Part-to-part skew				500	ps
t <sub>r</sub>	Rise time (see Figure 3)	V <sub>O</sub> = 0.4 V to 2 V	0.7		2	V/ns
t <sub>f</sub>	Fall time (see Figure 3)	V <sub>O</sub> = 2 V to 0.4 V	0.7		2	V/ns
t <sub>en</sub>	G before CLK ↓ (see Figure 1)	V <sub>(threshold)</sub> = V <sub>DD</sub> /2	0.1			ns
t <sub>dis</sub>	G after CLK ↓ (see Figure 1)		0.4			

† All typical values are at respective nominal V<sub>DD</sub>.

NOTE 4: The t<sub>sk(o)</sub> specification is only valid for equal loading of all outputs.

**$V_{DD} = 2.5\text{ V} \pm 0.2\text{ V}$  (see Figure 2)**

PARAMETER		TEST CONDITIONS	MIN	TYP†	MAX	UNIT
t <sub>PLH</sub>	CLK to Y <sub>n</sub> (see Figure 2)	f = 0 MHz to 170 MHz	1.5		3.5	ns
t <sub>PHL</sub>						
t <sub>sk(o)</sub>	Output skew (Y <sub>n</sub> to Y <sub>n</sub> ) (see Note 4 and Figure 4)				170	ps
t <sub>sk(p)</sub>	Pulse skew (see Figure 5)				400	ps
t <sub>sk(pp)</sub>	Part-to-part skew				600	ps
t <sub>r</sub>	Rise time (see Figure 3)	V <sub>O</sub> = 0.4 V to 1.7 V	0.5		1.4	V/ns
t <sub>f</sub>	Fall time (see Figure 3)	V <sub>O</sub> = 1.7 V to 0.4 V	0.5		1.4	V/ns
t <sub>en</sub>	G before CLK ↓ (see Figure 1)	V <sub>(threshold)</sub> = V <sub>DD</sub> /2	0.1			ns
t <sub>dis</sub>	G after CLK ↓ (see Figure 1)		0.4			

† All typical values are at respective nominal V<sub>DD</sub>.

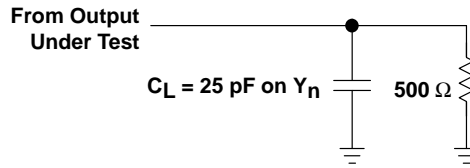
NOTE 4: The t<sub>sk(o)</sub> specification is only valid for equal loading of all outputs.

# CDCVF2310

## 2.5-V TO 3.3-V HIGH PERFORMANCE CLOCK BUFFER

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### PARAMETER MEASUREMENT INFORMATION



- NOTES: A.  $C_L$  includes probe and jig capacitance.  
 B. All input pulses are supplied by generators having the following characteristics:  $PRR \leq 200 \text{ MHz}$ ,  $Z_O = 50 \Omega$ ,  $t_r < 1.2 \text{ ns}$ ,  $t_f < 1.2 \text{ ns}$ .

Figure 2. Test Load Circuit

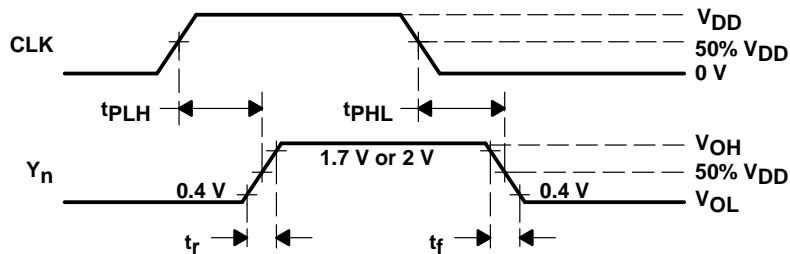


Figure 3. Voltage Waveforms Propagation Delay Times

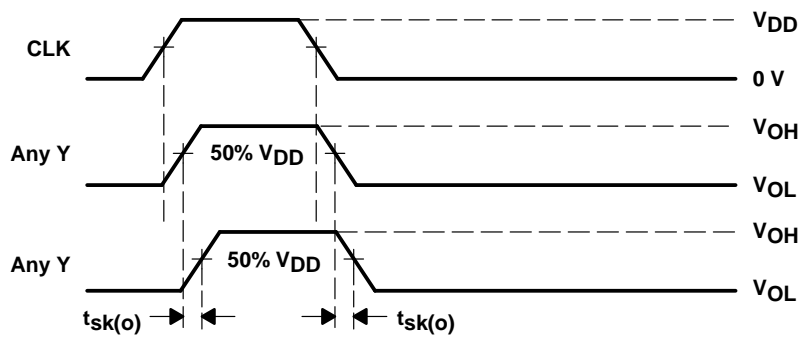
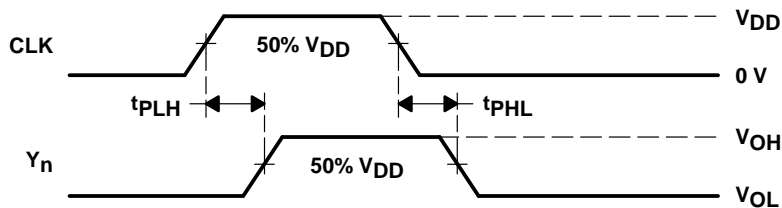


Figure 4. Output Skew

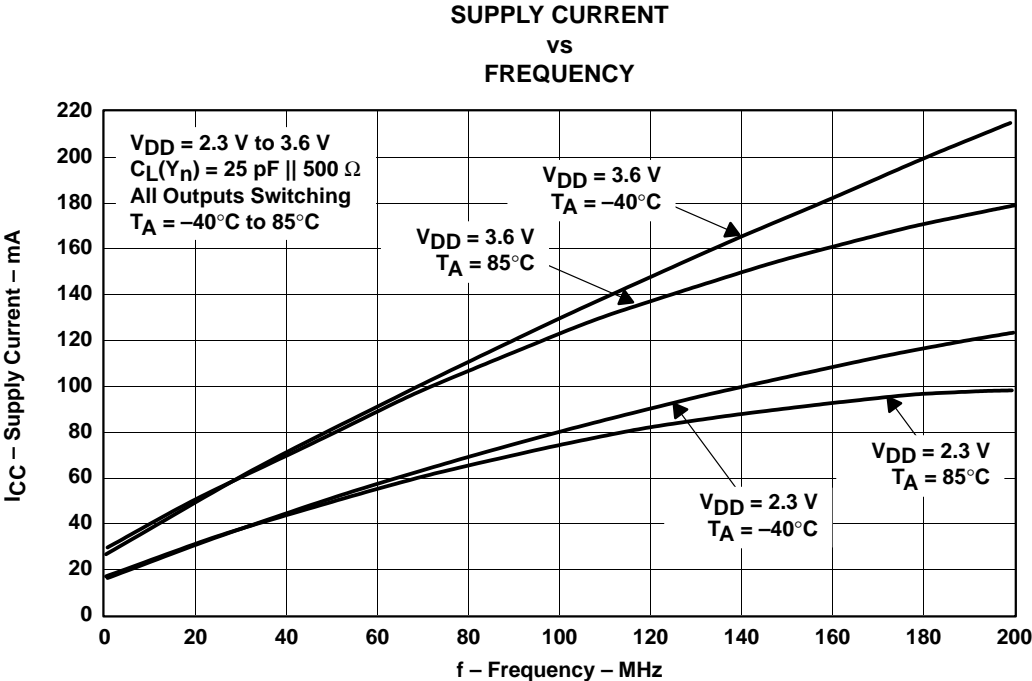


NOTE:  $t_{sk(p)} = |t_{PLH} - t_{PHL}|$

Figure 5. Pulse Skew



PARAMETER MEASUREMENT INFORMATION



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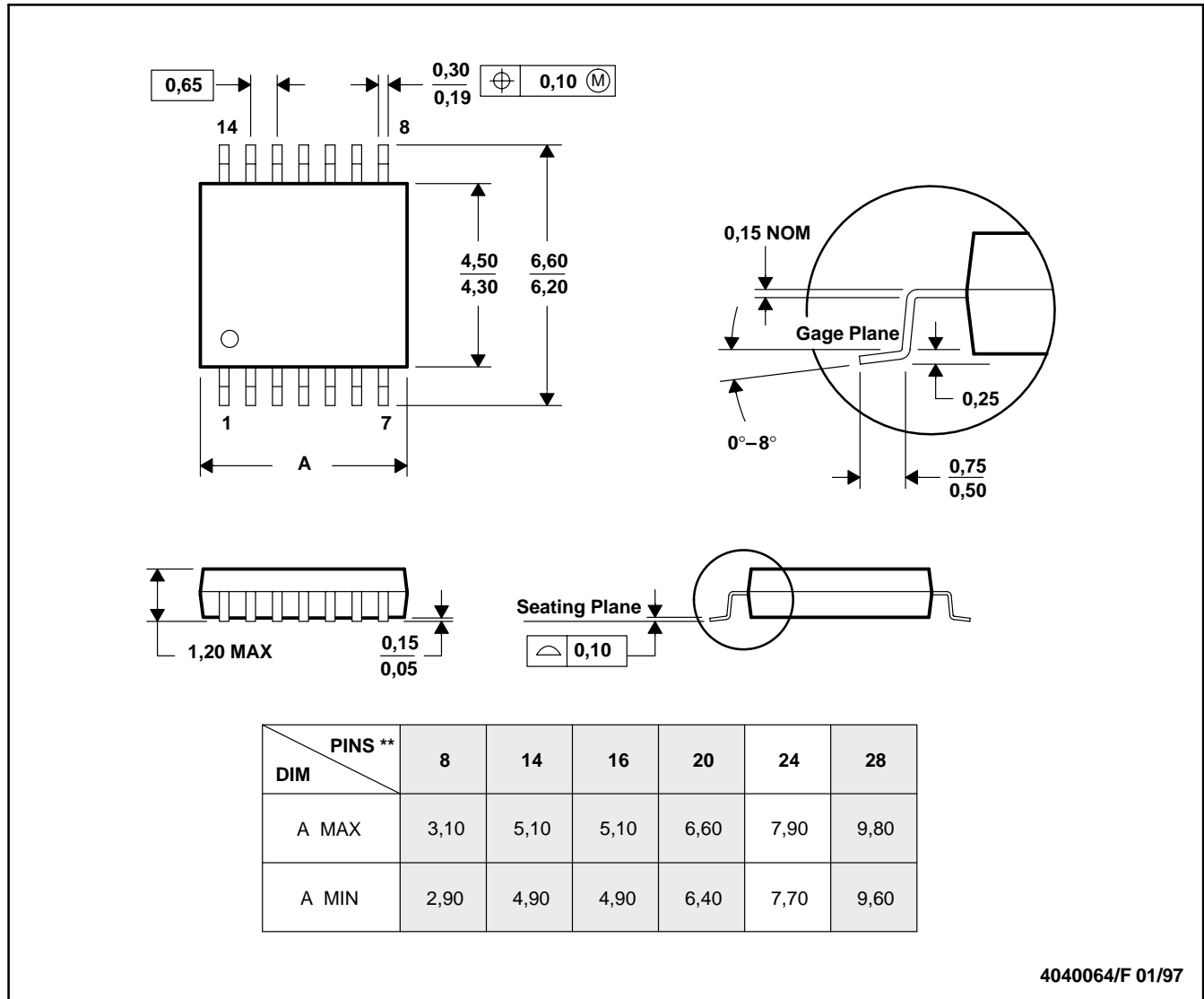
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## MECHANICAL DATA

PW (R-PDSO-G\*\*)

PLASTIC SMALL-OUTLINE PACKAGE

14 PINS SHOWN



- NOTES: A. All linear dimensions are in millimeters.  
 B. This drawing is subject to change without notice.  
 C. Body dimensions do not include mold flash or protrusion not to exceed 0,15.  
 D. Falls within JEDEC MO-153

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